

# STGP10NB60SFP

N-CHANNEL 10A - 600V - TO-220FP PowerMesh™ IGBT

TYPE	V <sub>CES</sub>	V <sub>CE(sat)</sub>	Ic
STGP10NB60SFP	600	< 1.7 V	10 A

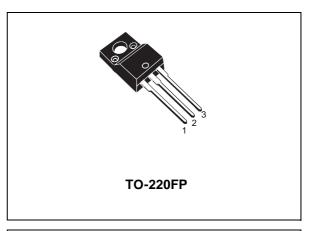
- HIGHT INPUT IMPEDANCE (VOLTAGE DRIVEN)
- LOW ON-VOLTAGE DROP
- HIGH CURRENT CAPABILITY
- OFF LOSSES INCLUDE TAIL CURRENT

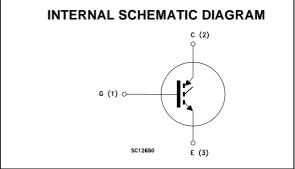


Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESH™ IGBTs, with outstanding performances. The suffix "S" identifies a family optimized achieve minimum on-voltage drop for low frequency applications (<1kHz).

#### **APPLICATIONS**

- LIGHT DIMMER
- STATIC RELAYS
- MOTOR CONTROL





#### **ABSOLUTE MAXIMUM RATINGS**

Symbol	Parameter	Value	Unit
V <sub>CES</sub>	Collector-Emitter Voltage (V <sub>GS</sub> = 0)	600	V
V <sub>ECR</sub>	Reverse Battery Protection	20	V
V <sub>GE</sub>	Gate-Emitter Voltage	± 20	V
Ic	Collector Current (continuous) at T <sub>C</sub> = 25°C	20	Α
I <sub>C</sub>	Collector Current (continuous) at T <sub>C</sub> = 100°C	10	Α
I <sub>CM</sub> (■)	Collector Current (pulsed)	80	А
P <sub>TOT</sub>	Total Dissipation at T <sub>C</sub> = 25°C	31.5	W
	Derating Factor	0.21	W/°C
T <sub>stg</sub>	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area

June 2002 1/8

## STGP10NB60SFP

#### THERMAL DATA

Rthj-case	Thermal Resistance Junction-case Max	4.7	°C/W
Rthj-amb	Thermal Resistance Junction-ambient Max	62.5	°C/W
Rthc-sink	Thermal Resistance Case-sink Typ	0.5	°C/W

# **ELECTRICAL CHARACTERISTICS** (TCASE = 25 °C UNLESS OTHERWISE SPECIFIED) OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>BR(CES)</sub>	Collector-Emitter Break-down Voltage	$I_C = 250 \mu A, V_{GE} = 0,$	600			V
V <sub>BR(CES)</sub>	Emitter Collector Break-down Voltage	$I_C = 1 \text{ mA}, V_{GE} = 0,$	20			V
I <sub>CES</sub>	Collector cut-off Current (V <sub>GE</sub> = 0)	$V_{CE}$ = Max Rating , $T_j$ =25 °C $V_{CE}$ = Max Rating , $T_j$ =125 °C			10 100	μA μA
I <sub>GES</sub>	Gate-Emitter Leakage Current (V <sub>CE</sub> = 0)	V <sub>GE</sub> = ± 20V , V <sub>CE</sub> = 0			± 100	nA

# ON (1)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{CE} = V_{GE}$ , $I_C = 250\mu A$	2.5		5	V
V <sub>CE(SAT)</sub>	Collector-Emitter Saturation Voltage	V <sub>GE</sub> =15V, I <sub>C</sub> = 5 A, Tj= 25°C V <sub>GE</sub> =15V, I <sub>C</sub> = 10 A, Tj= 25°C V <sub>GE</sub> =15V, I <sub>C</sub> = 10 A, Tj= 125°C		1.15 1.35 1.25	1.7	V V V

### **DYNAMIC**

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
9fs	Forward Transconductance	V <sub>CE</sub> = 25 V , I <sub>C</sub> =10 A	5			S
C <sub>ies</sub>	Input Capacitance	$V_{CE} = 25V, f = 1 \text{ MHz}, V_{GE} = 0$		610		pF
Coes	Output Capacitance			65		pF
C <sub>res</sub>	Reverse Transfer Capacitance			12		pF
Qg	Gate Charge	V <sub>CE</sub> = 400V, I <sub>C</sub> = 10 A, V <sub>GE</sub> = 15V		33		nC
I <sub>CL</sub>	Latching Current	V <sub>clamp</sub> = 480V, RG= 1kΩ, Tj= 125°C	20			А

2/8

#### SWITCHING ON

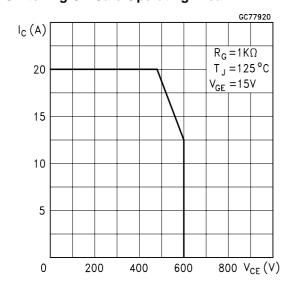
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>CC</sub> = 480 V, I <sub>C</sub> = 10 A		0.7		μs
t <sub>r</sub>	Rise Time	$R_G = 1K\Omega$ , $V_{GE} = 15 V$		0.46		μs
(di/dt) <sub>on</sub> Eon	Turn-on Current Slope Turn-on Switching Losses	$V_{CC}$ = 480 V, $I_{C}$ = 10 A $R_{G}$ =1K $\Omega$ , $V_{GE}$ = 15 V		8 0.6		A/µs mJ

### **SWITCHING OFF**

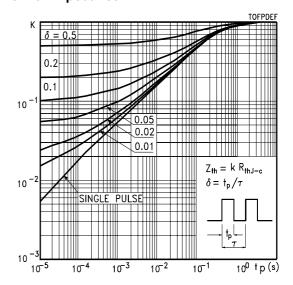
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
t <sub>c</sub>	Cross-over Time	V <sub>clamp</sub> = 480 V, I <sub>C</sub> = 10 A,		2.2		μs
$t_r(V_{off})$	Off Voltage Rise Time	$R_{GE} = 1K \Omega$ , $V_{GE} = 15 V$		1.2		μs
t <sub>f</sub>	Fall Time			1.2		μs
E <sub>off</sub> (**)	Turn-off Switching Loss			5.0		mJ
t <sub>c</sub>	Cross-over Time	$V_{clamp} = 480 \text{ V}, I_{C} = 10 \text{ A},$		3.8		μs
$t_r(V_{off})$	Off Voltage Rise Time	$R_{GE} = 1K\Omega$ , $V_{GE} = 15 V$ Ti = 125 °C		1.2		μs
t <sub>f</sub>	Fall Time	., = 123 3		1.9		μs
E <sub>off</sub> (**)	Turn-off Switching Loss			8.0		mJ

<sup>(●)</sup>Pulsed: Pulse duration = 300 µs, duty cycle 1.5 %. (1)Pulse width limited by max. junction temperature. (\*\*)Losses Include Also the Tail

## **Switching Off Safe Operating Area**



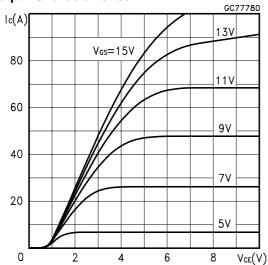
### **Thermal Impedance**



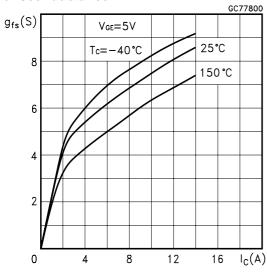
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#### STGP10NB60SFP

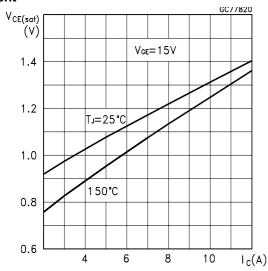
### **Output Characteristics**



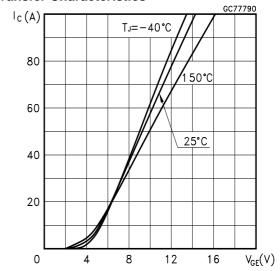
# Transconductance



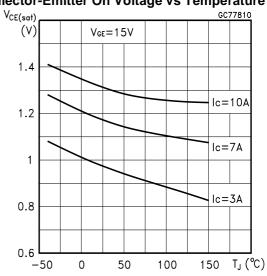
# Collector-Emitter On Voltage vs Collector Current



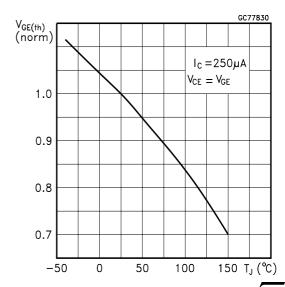
#### **Transfer Characteristics**



### Collector-Emitter On Voltage vs Temperature

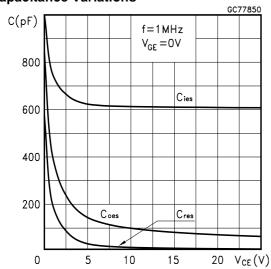


**Gate Threshold Voltage vs Temperature** 

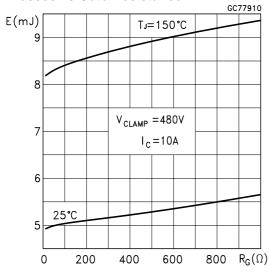


4/8

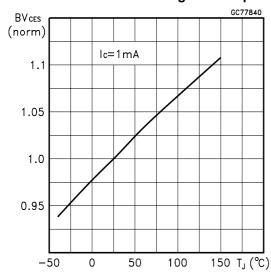
## **Capacitance Variations**



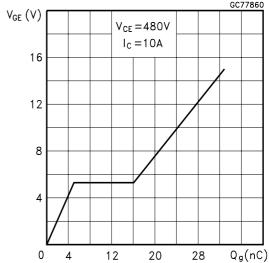
#### Off Losses vs Gate Resistance



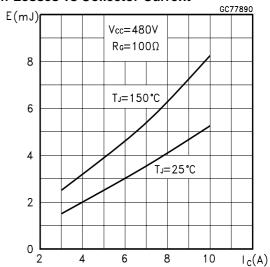
## Normalized Break-down Voltage vs Temp.



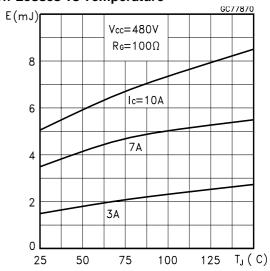
# **Gate Charge vs Gate-Emitter Voltage**



#### **Off Losses vs Collector Current**



# Off Losses vs Temperature

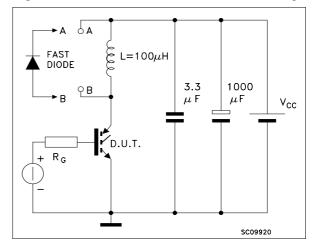


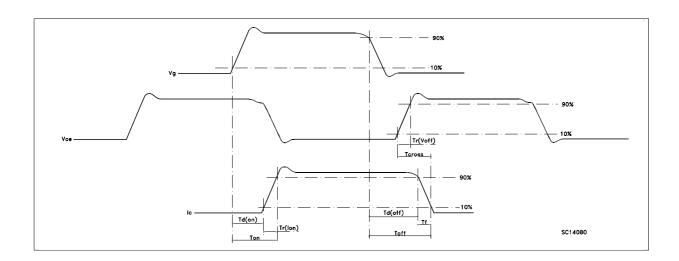
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Fig. 1: Gate Charge test Circuit

 $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$   $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$   $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$   $V_{\rm I} = 20 {\rm V} = {\rm V}_{\rm GMAX}$   $V_{\rm I} = {\rm I}_{\rm I} = {\rm I}_$ 

Fig. 2: Test Circuit For Inductive Load Switching

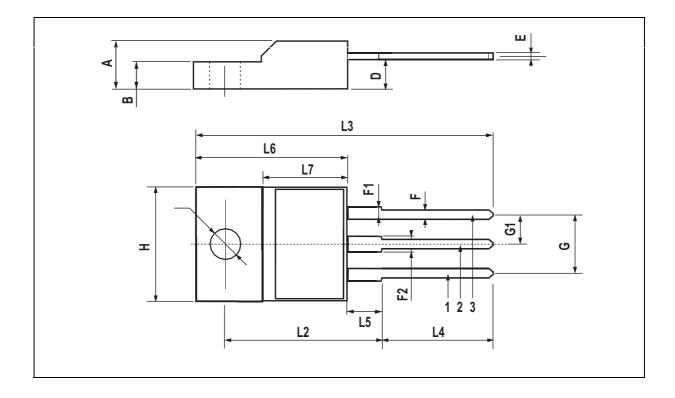




6/8

# **TO-220FP MECHANICAL DATA**

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
А	4.4		4.6	0.173		0.181
В	2.5		2.7	0.098		0.106
D	2.5		2.75	0.098		0.108
Е	0.45		0.7	0.017		0.027
F	0.75		1	0.030		0.039
F1	1.15		1.5	0.045		0.067
F2	1.15		1.5	0.045		0.067
G	4.95		5.2	0.195		0.204
G1	2.4		2.7	0.094		0.106
Н	10		10.4	0.393		0.409
L2		16			0.630	
L3	28.6		30.6	1.126		1.204
L4	9.8		10.6	.0385		0.417
L5	2.9		3.6	0.114		0.141
L6	15.9		16.4	0.626		0.645
L7	9		9.3	0.354		0.366
Ø	3		3.2	0.118		0.126



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**477**° 8/8